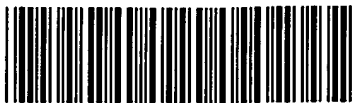


**Search Notes**

Application/Control No.

10/695,221

Examiner

Hai L. Nguyen

Applicant(s)/Patent under  
Reexamination

LUNDBERG, JAMES R.

Art Unit

2816

**SEARCHED**

Class	Subclass	Date	Examiner
327	291-294, 298, 299	3/12/2007	HLN
327	165	3/13/2007	HLN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Text Search, see search history printout	3/13/2007	HLN
Shepardize Search, see search history printout	3/13/2007	HLN